



GL8N120A47

Silicon N-Channel Power MOSFET

General Description

GL8N120A47, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-247, which accords with the RoHS standard.

Features

- Fast Switching
- Low ON Resistance
- Low Gate Charge Minimize Switching loss
- Fast Recovery Body Diode
- 100% Single Pulse avalanche energy Test

Applications

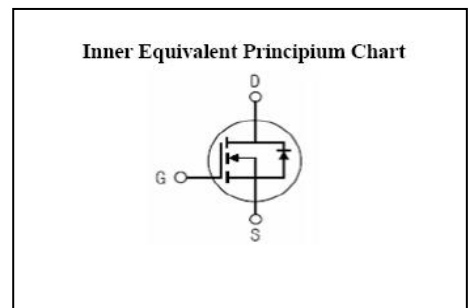
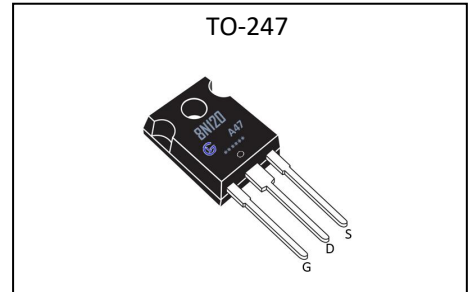
- Adaptor
- Charger
- SMPS Standby Power

Absolute (Tc= 25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage	1200	V
I _D	Continuous Drain Current	8	A
I _{DM}	Pulsed Drain Current at V _{GS} =10V	32	A
V _{GS}	Gate-to-Source Voltage	± 30	V
E _{AS}	Single Pulse Avalanche Energy	600	mJ
dv/dt	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	335	W
	Derating Factor above 25°C	2.68	W/°C
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T _L	Maximum Temperature for Soldering	300	°C
T _{PAK}	Leads at 0.63 in(1.6mm) from Case for 10 seconds, Package Body for 10 seconds	260	°C

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

V _{DSS}	1200	V
I _D	8	A
P _D (T _C =25°C)	335	W
R _{DS(ON).type.}	1.6	Ω





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Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.37	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	50	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics ($T_c = 25^{\circ}\text{C}$ unless otherwise specified) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	1200	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}, T_a = 25^{\circ}\text{C}$	--	--	10	μA
		$V_{DS} = 960\text{V}, V_{GS} = 0\text{V}, T_a = 125^{\circ}\text{C}$	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS} = +30\text{V}$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS} = -30\text{V}$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS} = 10\text{V}, I_D = 4\text{A}$	--	1.6	2.0	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	3	--	5	V
g_{fs}	Forward Transconductance	$V_{DS} = 50\text{V}, I_D = 3\text{A}$	--	8	--	S

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$	--	2730	--	pF
C_{oss}	Output Capacitance		--	250	--	
C_{rss}	Reverse Transfer Capacitance		--	38	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D = 3\text{A}, V_{DD} = 600\text{V}$ $V_{GS} = 15\text{V}, R_g = 4.7\Omega$	--	15	--	ns
t_r	Rise Time		--	10	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	50	--	
t_f	Fall Time		--	33	--	
Q_g	Total Gate Charge	$I_D = 3\text{A}, V_{DD} = 600\text{V}$ $V_{GS} = 10\text{V}$	--	75	--	nC
Q_{gs}	Gate to Source Charge		--	16	--	
Q_{gd}	Gate to Drain ("Miller") Charge		--	32	--	



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Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_{SD}	Continuous Source Current (Body Diode)		--	--	8	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	32	A
V_{SD}	Diode Forward Voltage	$I_S=8A, V_{GS}=0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_S=8A, T_j=25^\circ C$	--	1100	--	ns
Q_{rr}	Reverse Recovery Charge	$di/dt=100A/\mu s, V_{GS}=0V$	--	15	--	μC

*Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$



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Characteristics Curves

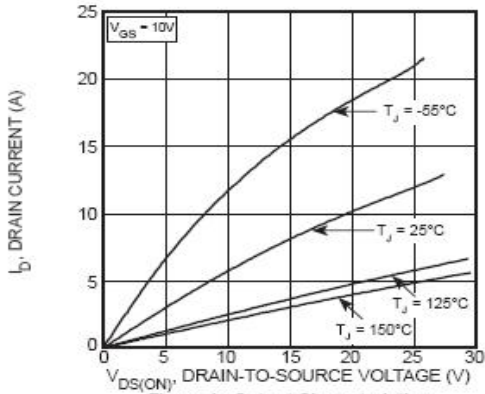


Figure 1, Output Characteristics

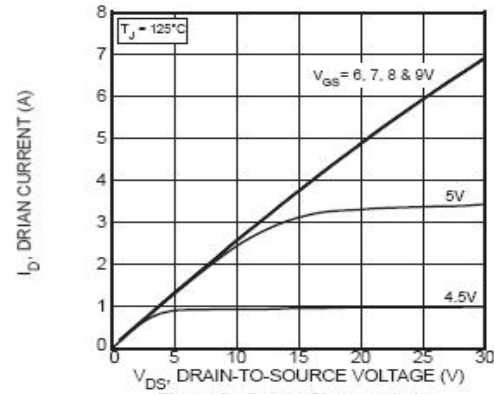


Figure 2, Output Characteristics

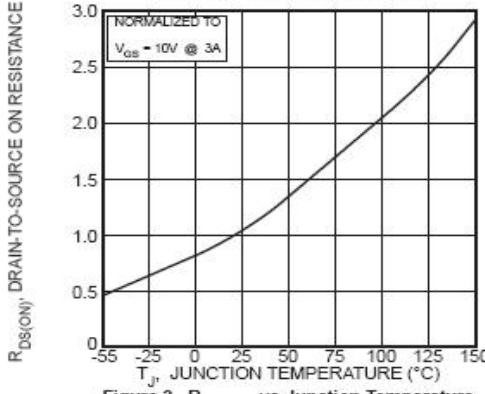


Figure 3, $R_{DS(ON)}$ vs Junction Temperature

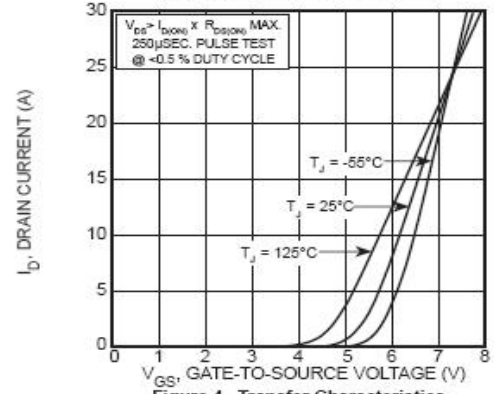


Figure 4, Transfer Characteristics

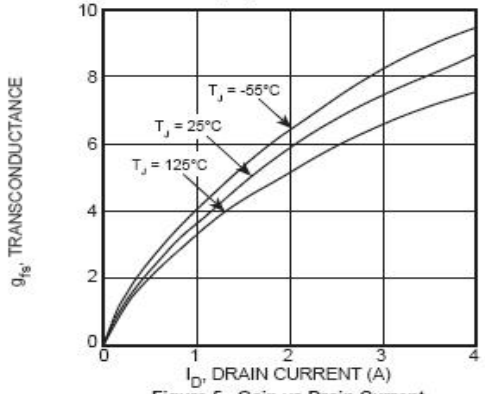


Figure 5, Gain vs Drain Current

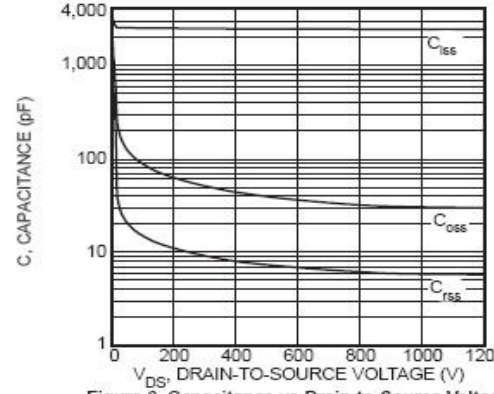


Figure 6, Capacitance vs Drain-to-Source Voltage

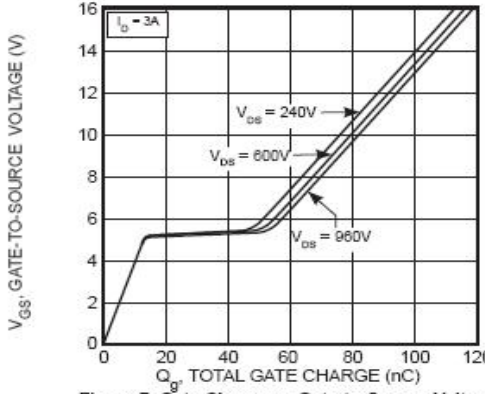


Figure 7, Gate Charge vs Gate-to-Source Voltage

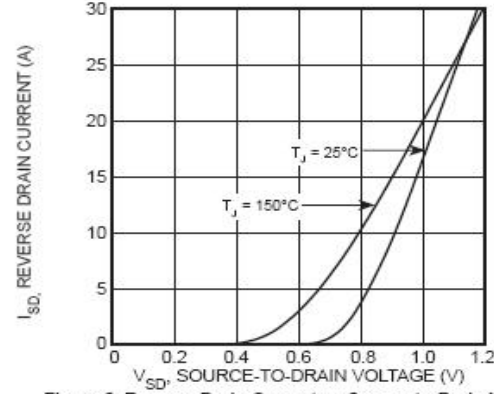


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



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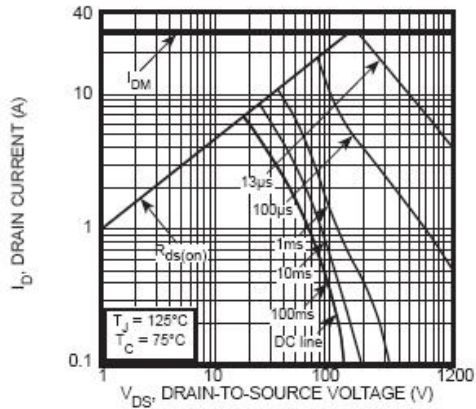


Figure 9, Forward Safe Operating Area

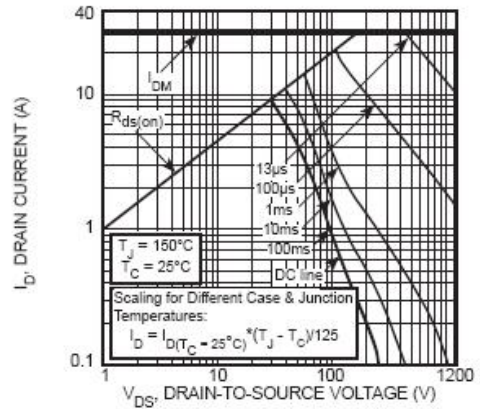


Figure 10, Maximum Forward Safe Operating Area

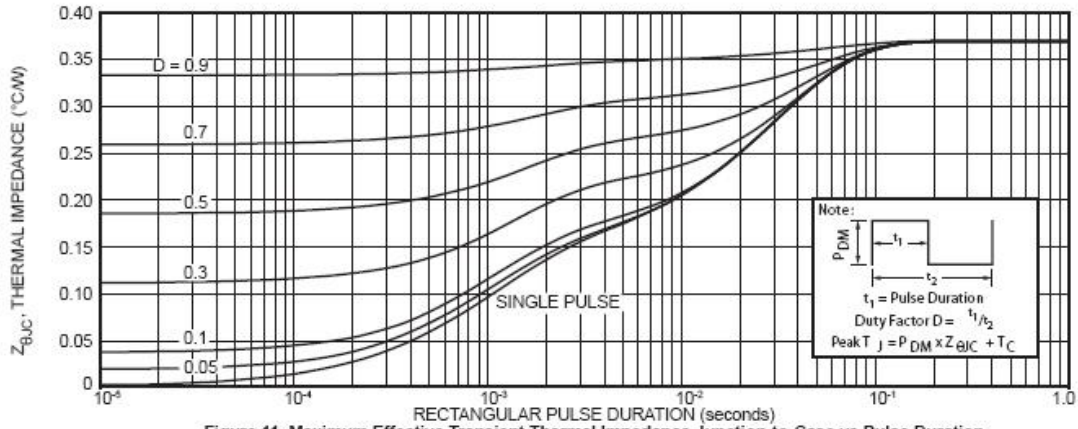


Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs. Pulse Duration